

<b>Notice of References Cited</b>	Application/Control No. 10/795,771		Applicant(s)/Patent Under Reexamination SHAN ET AL.	
	Examiner Timothy C. Vanoy		Art Unit 1754	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,696,258 B1	02-2004	Wei et al.	435/7.2
*	B	US-6,814,950 B1	11-2004	Shan et al.	423/326
	C	US-			
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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